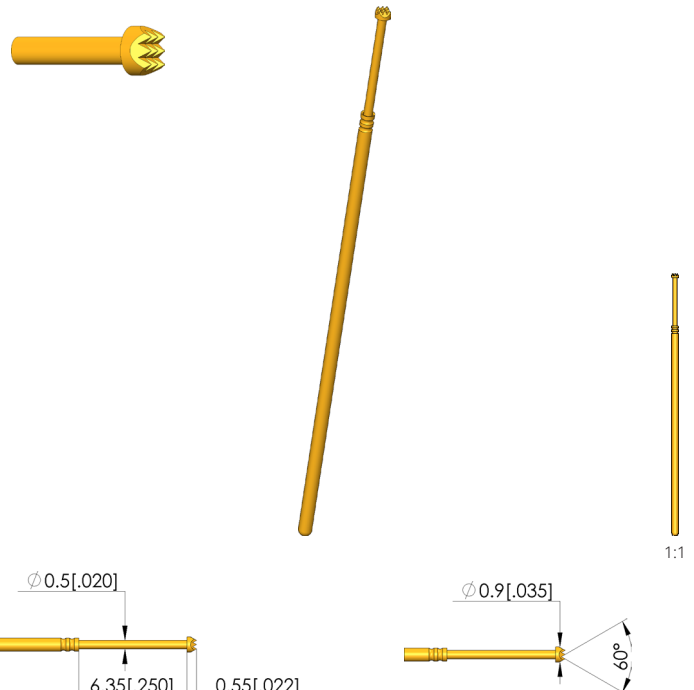




GO TO PRODUCT

- Robust, compact design for harsh ICT/FCT applications with limited space
- For optimum contact at the test points (e.g. pads, vias, and pins), various tip styles in different diameters and finishes, as well as various spring forces are available. Spring forces.



General data

Product group:
Sub-product group:
Series:
Grid:
Contacting from:
Magnetic:
Installation type:
Quick-exchange system:
Adjustable installation height:
Non-rotating:
Compatible receptacle(s):
Min. temperature:
Max. temperature:
RoHS-compliant:

ICT / FCT (in-circuit test and function test)
Bead probe
GKS-550
1.27 mm [50 mil]
Post
Yes
Plug-in
Yes
No
No
KS-550 WL
-40 °C [-40 °F]
80 °C [176 °F]
Yes

Tip style data

Tip style:
Tip diameter:
Tip style surface:
Tip style material:

60 serrated, small grid
0.9 mm [0.035 in]
A gold
3 CuBe

Electrical data

Current load capacity / rated current:
Typical resistance (Ri):

3 A
20 mOhm

Mechanical data

Total length:
Barrel diameter:
Maximum stroke:
Spring pre-load:
Collar height:
Spring force at working stroke:
Recommended working stroke:

34.6 mm [1.36 in]
0.78 mm [0.03 in]
6.35 mm [0.25 in]
0.66 N [2.37 ozf]
0
1.5 N [5.39 ozf]
4.3 mm [0.169 in]

Test Probe

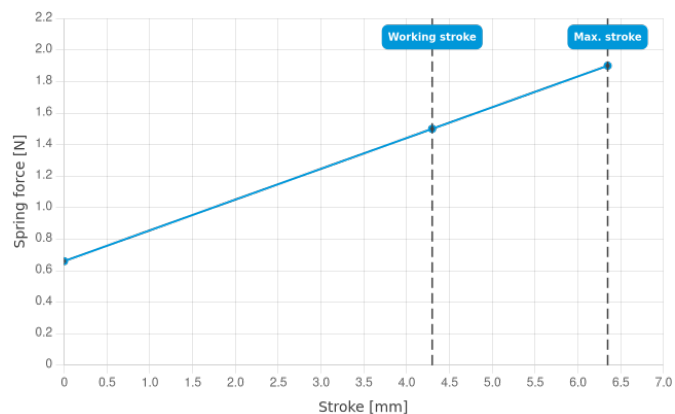
GKS-550 360 090 A 1500

Item GKS-550-0022



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Prices and delivery times on request.
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